MSKSEMI 美森科













ESD

1/5

TSS

MOV

GDT

 PLED

MSiRA18BDP

Product specification





Description

The MSiRA18BDP uses advanced trench technology to provide excellent RDS(ON), low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

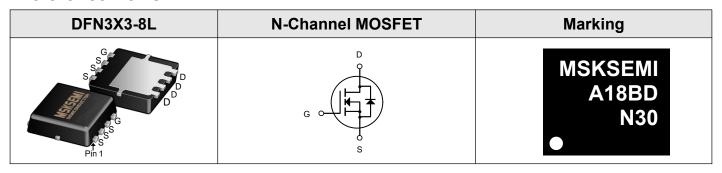
Features

- V_{DS} = 30V I_D = 45A
- RDS(ON) $< 8m\Omega$ @ VGS= 10V

Application

- Battery protection
- Load switch
- Uninterruptible power supply

Reference News



Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

Symbol	Parameter	Rating	Units
Vos	Drain-Source Voltage	30	V
Vgs	Gate-Source Voltage	±20	V
lo@Tc=25℃	Continuous Drain Current, V _{GS} @ 10V¹	45	Α
l b@Tc=100℃	Continuous Drain Current, V _{GS} @ 10V¹	32	Α
Ірм	Pulsed Drain Current ²	140	Α
EAS	Single Pulse Avalanche Energy ³	115.2	mJ
las	Avalanche Current	48	Α
P 	Total Power Dissipation ⁴	59	W
Тѕтс	Storage Temperature Range	-55 to 150	$^{\circ}$
TJ	Operating Junction Temperature Range	-55 to 150	$^{\circ}$
Reja	Thermal Resistance Junction-ambient ¹	62	°C/W
Rejc	Thermal Resistance Junction-Case ¹	2.1	°C/W



Electrical Characteristics (TJ=25 ℃ unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	Vgs=0V , ID=250uA	30			V
△BVɒss/△Tɹ	BVDSS Temperature Coefficient	Reference to 25℃ l _D =1mA '		0.027		V/°C
		Vgs=10V , ID=20A		6	8	
RDS(ON)	Static Drain-Source On- Resistance ²	Vgs=4.5V , ID=10A		7.5	10	mΩ
$V_{GS(th)}$	Gate Threshold Voltage		1.2		2.5	V
$\triangle V$ GS(th)	V _{GS(th)} Temperature Coefficient	Vgs=Vds , Id =250uA		-5.8		mV/℃
loss	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =25℃			1	
		V _{DS} =24V , V _{GS} =0V , T _J =55℃			5	uA
Igss	Gate-Source Leakage Current	Vgs=±20V , Vps=0V			±100	nA
gfs	Forward Transconductance	VDS=5V , ID=30A		43		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.7		Ω
Q_g	Total Gate Charge (4.5V)			20		
Qgs	Gate-Source Charge	V _{DS} =15V , V _{GS} =4.5V		7.6		
Qgd	Gate-Drain Charge	, l₀=15A		7.2		nC
T _{d(on)}	Turn-On Delay Time			7.8		
Tr	Rise Time	V _{DD} =15V , V _{GS} =10V		15		
T _d (off)	Turn-Off Delay Time	, R _G =3.3 Ω		37.3		ns
Tf	Fall Time	lo=15A		10.6		110
Ciss	Input Capacitance			2295		
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V ,		267		_
Crss	Reverse Transfer Capacitance	f=1MHz		210		pF
l s	Continuous Source Current ^{1,6}	V _G =V _D =0V , Force			45	Α
Іѕм	Pulsed Source Current ^{2,6}	Current			140	Α
Vsb	Diode Forward Voltage ²	V ss=0V , Is=1A , TJ=25℃			1	V

Note:

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width $\leqq 300 \text{us}$, duty cycle $\, \leqq \, 2\%$
- 3 .The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V,L=0.1mH,Ias=34A
- 4.The power dissipation is limited by 150 $\!\!\!^{\,\circ}\!\!\!^{\,\circ}$ junction temperature
- 5 .The data is theoretically the same as I_{D} and I_{DM} , in real applications , should be limited by total power dissipation.



Typical Characteristics

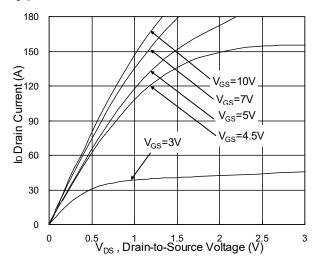


Fig.1 Typical Output Characteristics

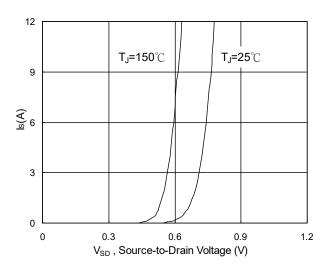


Fig.3 Forward Characteristics of Reverse

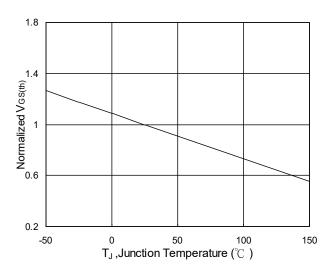


Fig.5 Normalized V_{GS(th)} vs. T_J

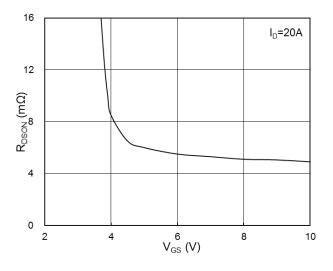


Fig.2 On-Resistance vs. G-S Voltage

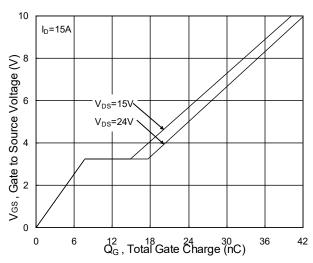


Fig.4 Gate-Charge Characteristics

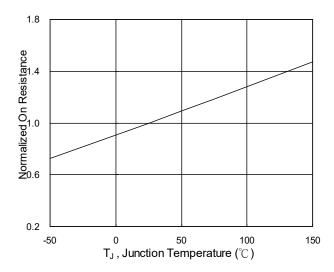
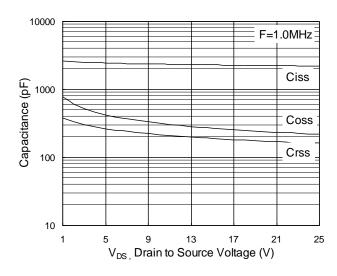


Fig.6 Normalized R_{DSON} vs. T_J





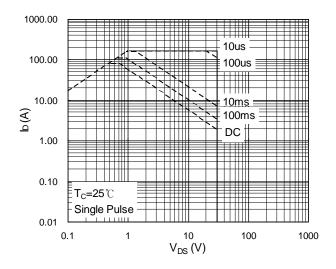


Fig.7 Capacitance

Fig.8 Safe Operating Area

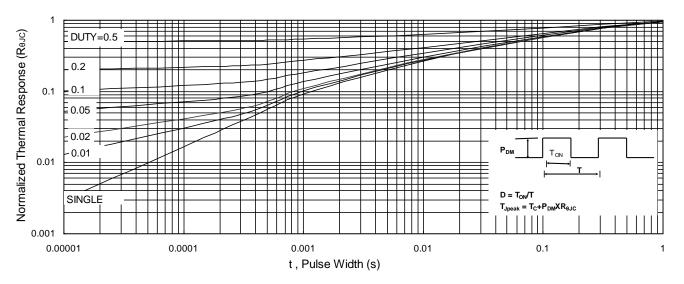


Fig.9 Normalized Maximum Transient Thermal Impedance

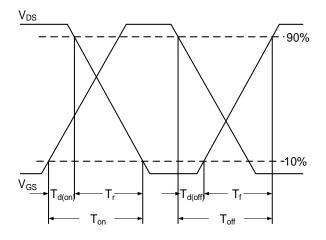


Fig.10 Switching Time Waveform

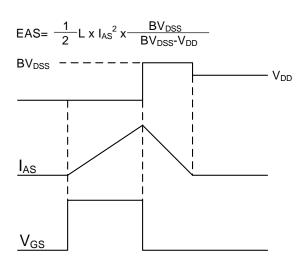
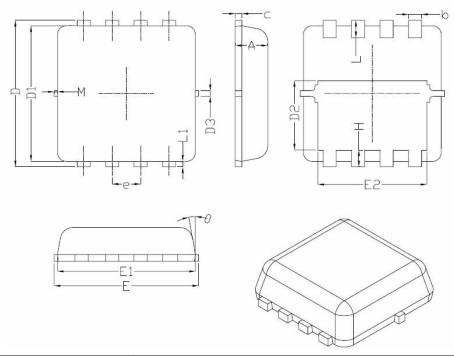


Fig.11 Unclamped Inductive Switching Waveform



DFN3X3-8L Package Information



Symbol	Dimensions In Millimeters		
Symbol	Min.	Nom.	Max.
Ab	0.70	0.75	0.80
	0.25	0.30	0.35
С	0.10	0.15	0.25
D	3.25	3.35	3.45
D1	3.00	3.10	3.20
D2	1.48	1.58	1.68
D3	-	0.13	-
E	3.20	3.30	3.40
E1E	3.00	3.15	3.20
2	2.39	2.49	2.59
е	0.65BSC		
Н	0.30	0.39	0.50
L	0.30	0.40	0.50
L1	-	0.13	-
M	*	*	0.15
θ		10 °	12 °

REEL SPECIFICATION

P/N	PKG	QTY
MSiRA18BDP	DFN3X3-8L	5000



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